TOSHIBA

TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

TC74VHCT373AF,TC74VHCT373AFT,TC74VHCT373AFK

Octal D-Type Latch with 3-State Output

The TC74VHCT373A is an advanced high speed CMOS OCTAL LATCH with 3-STATE OUTPUT fabricated with silicon gate C²MOS technology.

It achieves the high speed operation similar to equivalent Bipolar Schottky TTL while maintaining the CMOS low power dissipation.

This 8-bit D-type latch is controlled by a latch enable input (LE) and an output enable input ($\overline{\text{OE}}$).

When the \overline{OE} input is high, the eight outputs are in a high impedance state.

The input voltage are compatible with TTL output voltage.

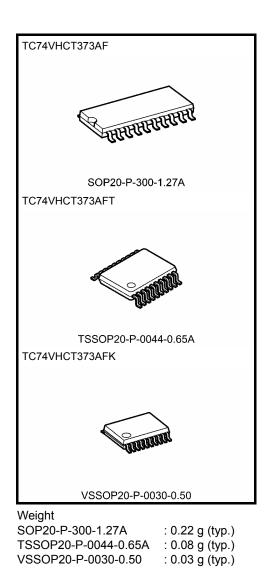
This device may be used as a level converter for interfacing 3.3 V to 5 V system.

Input protection and output circuit ensure that 0 to 5.5 V can be applied to the input and output ^(Note) pins without regard to the supply voltage. These structure prevents device destruction due to mismatched supply and input/output voltages such as battery back up, hot board insertion, etc.

Note: Output in off-state

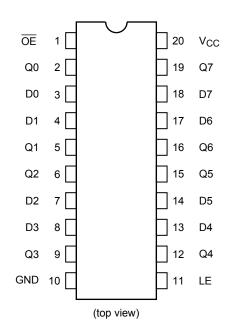
Features

- High speed: $t_{pd} = 7.7$ ns (typ.) at $V_{CC} = 5$ V
- Low power dissipation: $I_{CC} = 4 \mu A \pmod{at Ta} = 25^{\circ}C$
- Compatible with TTL outputs: $V_{IL} = 0.8 V (max)$
- $V_{IH} = 2.0 V (min)$
- Power down protection is provided on all inputs and outputs.
- Balanced propagation delays: $t_{pLH} \simeq t_{pHL}$
- Low noise: VOLP = 1.6 V (max)
- Pin and function compatible with the 74 series (74AC/HC/F/ALS/LS etc.) 373 type.



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Pin Assignment



IEC Logic Symbol

		_
OE(1) LE(11)	EN C1	
D0 <u>(3)</u>	1D ▷ ▽	(<u>2</u>) Q0
D1 <u>(4)</u>		(<u>5)</u> Q1
D2(7)	-	(6) Q2
D3 <u>(8)</u>		(9) Q3
(13)		(12)
D4 - (14)		(15)
D5 — —		
D6 <u>(17)</u>		<u>(16)</u> Q6
(18)		(<u>19</u>) Q7
01		Q1

Truth Table

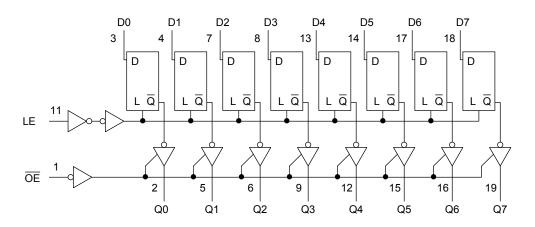
	Inputs	Output			
ŌĒ	LE	D	Output		
Н	Х	Х	Z		
L	L	Х	Qn		
L	Н	L	L		
L	Н	Н	Н		

X: Don't care

Z: High impedance

 $\mathsf{Q}_n:\mathsf{Q}$ outputs are latched at the time when the LE input is taken to a low logic level.

System Diagram



Absolute Maximum Ratings (Note 1)

Characteristics	Symbol	Rating	Unit
Supply voltage range	V _{CC}	-0.5 to 7.0	V
DC input voltage	V _{IN}	-0.5 to 7.0	V
DC output voltage	Vaum	-0.5 to 7.0 (Note 2)	V
	Vout	-0.5 to V _{CC} + 0.5 (Note 3)	v
Input diode current	lık	-20	mA
Output diode current	I _{ОК}	±20 (Note 4)	mA
DC output current	IOUT	±25	mA
DC V _{CC} /ground current	ICC	±75	mA
Power dissipation	PD	180	mW
Storage temperature	T _{stg}	-65 to 150	°C

Note 1: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note 2: Output in off-state

Note 3: High or low state. IOUT absolute maximum rating must be observed.

Note 4: V_{OUT} < GND, V_{OUT} > V_{CC}

Operating Ranges (Note 1)

Characteristics	Symbol	Rating	Unit
Supply voltage	V _{CC}	4.5 to 5.5	V
Input voltage	V _{IN}	0 to 5.5	V
Output voltage	V _{OUT}	0 to 5.5 (Note 2)	V
		0 to V _{CC} (Note 3)	v
Operating temperature	T _{opr}	-40 to 85	°C
Input rise and fall time	dt/dV	0 to 20	ns/V

Note 1: The operating ranges must be maintained to ensure the normal operation of the device. Unused inputs must be tied to either V_{CC} or GND.

Note 2: $V_{CC} = 0 V$

Note 3: High or low state

Electrical Characteristics

DC Characteristics

Characteristics Symbol		Test Condition			Ta = 25°C			Ta = −40 to 85°C		Unit
	,				Min	Тур.	Max	Min	Max	
High-level input voltage	V _{IH}		_	4.5 to 5.5	2.0	_	_	2.0	_	V
Low-level input voltage	V _{IL}		—	4.5 to 5.5		_	0.8		0.8	V
High-level output	Maria	V _{IN}	I _{OH} = -50 μA	4.5	4.40	4.50	—	4.40	—	V
voltage		= V _{IH} or V _{IL}	I _{OH} = −8 mA	4.5	3.94	—	—	3.80	—	v
Low-level output	V _{OL} = V	V _{IN} = V _{IH} or V _{IL}	I _{OL} = 50 μA	4.5		0.0	0.1		0.1	- v
voltage			I _{OL} = 8 mA	4.5		_	0.36		0.44	
3-state output off-state current	I _{OZ}	$V_{IN} = V_{IH} \text{ or } V_{IL}$ $V_{OUT} = V_{CC} \text{ or } GND$		5.5	_	_	±0.25	_	±2.50	μA
Input leakage current	I _{IN}	V _{IN} = 5.5 V or GND		0 to 5.5	_	_	±0.1	_	±1.0	μA
	ICC	V _{IN} = V _C	_C or GND	5.5		—	4.0		40.0	μA
ICCT		:: V _{IN} = 3.4 V put: V _{CC} or GND	5.5	_	_	1.35	_	1.50	mA	
Output leakage current	I _{OPD}	V _{OUT} = 5	5.5 V	0		_	0.5		5.0	μA

Timing Requirements (input: $t_r = t_f = 3 \text{ ns}$)

Characteristics	Symbol Test Condition			Ta = 25°C		Ta = −40 to 85°C	Unit
			V _{CC} (V)	Тур.	Limit	Limit	
Minimum pulse width (LE)	t _{w (H)}	-	5.0 ± 0.5	_	6.5	8.5	ns
Minimum set-up time	t _s	_	5.0 ± 0.5	-	1.5	1.5	ns
Minimum hold time	t _h	—	5.0 ± 0.5	_	3.5	3.5	ns

AC Characteristics (input: $t_r = t_f = 3 \text{ ns}$)

Characteristics	Symbol	Tes		t Condition		Ta = 25°C			Ta = −40 to 85°C			
			V _{CC} (V)	C _L (pF)	Min	Тур.	Max	Min	Max	Unit		
Propagation delay time	t _{pLH}	_	5.0 ± 0.5	15	_	7.7	12.3	1.0	13.5	ns		
(LE-Q)	t _{pHL}		0.0 1 0.0	50		8.5	13.3	1.0	14.5	110		
Propagation delay time	t _{pLH}	_	5.0 ± 0.5	15		5.1	8.5	1.0	9.5	ns		
(D-Q)	t _{pHL}		—		—	5.0 ± 0.5	50		5.9	9.5	1.0	10.5
3-state output enable	t _{pZL}	R _L = 1 kΩ	5.0 ± 0.5	15		6.3	10.9	1.0	12.5	ns		
time	t _{pZH}			50	—	7.1	11.9	1.0	13.5			
3-state output disable time	t _{pLZ} t _{pHZ}	R _L = 1 kΩ	5.0 ± 0.5	50	_	8.8	11.2	1.0	12.0	ns		
Output to output skew	t _{osLH} t _{osHL}	(Note 1)	5.0 ± 0.5	50	_	_	1.0	_	1.0	ns		
Input capacitance	CIN		_			4	10		10	pF		
Output capacitance	C _{OUT}		_		_	9	_	_	—	pF		
Power dissipation capacitance	C _{PD}			(Note 2)	_	25	_	_	_	pF		

Note 1: Parameter guaranteed by design.

 $t_{OSLH} = |t_{pLHm} - t_{pLHn}|, t_{OSHL} = |t_{pHLm} - t_{pHLn}|$

Note 2: C_{PD} is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

Average operating current can be obtained by the equation:

 $I_{CC (opr)} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}/8$ (per latch)

And the total C_{PD} when n pcs. of latch operate can be gained by the following equation:

C_{PD} (total) = 14 + 11·n

Noise Characteristics (input: t_r = t_f = 3 ns)

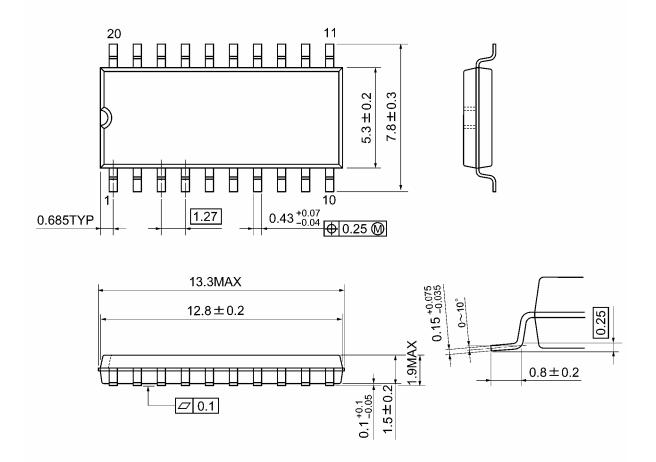
Characteristics	Symbol	Test Condition		Ta =	Unit	
Characteristics	Symbol		$V_{CC}(V)$	Тур.	Max	Unit
Quiet output maximum dynamic V_{OL}	V _{OLP}	C _L = 50 pF	5.0	1.1	1.5	V
Quiet output minimum dynamic V_{OL}	V _{OLV}	C _L = 50 pF	5.0	-1.1	-1.5	V
Minimum high level dynamic input voltage	VIHD	C _L = 50 pF	5.0	_	2.0	V
Maximum low level dynamic input voltage	V _{ILD}	C _L = 50 pF	5.0		0.8	V



Package Dimensions

SOP20-P-300-1.27A

Unit: mm



Weight: 0.22 g (typ.)

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Unit: mm

Package Dimensions

TSSOP20-P-0044-0.65A

20 П 11 || 6.4±0.2 **4.4±0.1** ₿ 10 Ħ Ħ Ħ Ħ Ħ Ħ Ħ Ţ Π $0.22\substack{+0.09\\-0.06}$ 0.65 0.325TYP ∲0.13∭ 6.9MAX 6.5±0.1 1.2MAX ╔<u></u>┲р┙ 0.15+0.03 * 0~10° 0.25 1.0±0.05 0.1±0.05 S ∠70.1S (0.5) 0.45~0.75

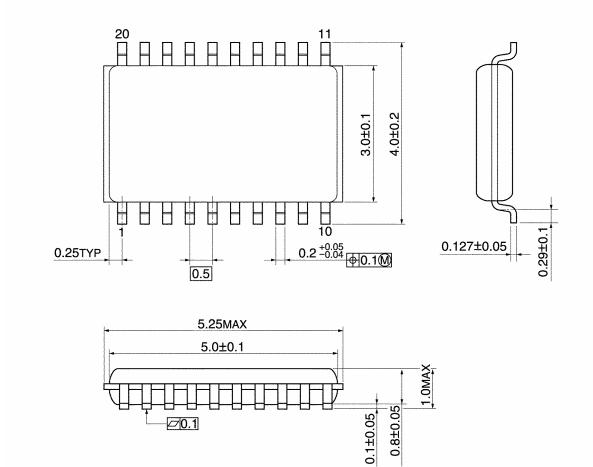
Weight: 0.08 g (typ.)

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Package Dimensions

VSSOP20-P-0030-0.50

Unit: mm



Weight: 0.03 g (typ.)

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20070701-EN GENERAL

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